



Zn₂SbN₃: Growth and Characterization of a Metastable Photoactive Semiconductor

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Conceptual Insights

Technological success of III-V semiconductors such as GaN has spurred research interest in growth and characterization of new semiconducting nitride materials. As a result, most of the elements in the periodic table have been reported to form crystalline nitrides, with exception of antimony (Sb). This motivated us to understand if this was a fundamental limitation of Sb, or if there were some Sb-based nitrides that remain to be discovered. This article reports on the theoretical discovery and experimental synthesis of Zn_2SbN_3 : the first Sb-based nitride and a photoactive semiconducting material. From chemical point of view, the main conceptual insights are: (i) that Sb can form nitrides, as has not been reported before; (ii) that in nitrides Sb can be in the +V oxidation state, the rarest and the highest that this element can achieve, and (iii) that Sb(+V) can assume tetrahedral coordination, which has never been reported. From physics standpoint, Zn_2SbN_3 displays compelling optoelectronic properties, such as room-temperature band-edge photoluminescence, semiconducting behavior, moderate electron density, an intermediate band gap, and favorable position of the band edges with respect to hydrogen evolution reaction. These properties make Zn_2SbN_3 a compelling absorber candidate for photovoltaic (PV) and photoelectrochemical (PEC) solar cells.

Zn₂SbN₃: Growth and Characterization of a Metastable Photoactive Semiconductor

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Abstract

Ternary nitride semiconductors with wurtzite-derived crystal structure is an emerging class of materials for optoelectronic applications compatible with GaN and related III-V compounds. In particular, II-IV-V₂ materials such as ZnSnN₂ and ZnGeN₂ have been very actively studied for applications in photovoltaic and light emitting devices. However, many other possible wurtzite-derived ternary nitrides have not been reported, and hence their optical and electrical properties remain unknown. Here, we report on Zn₂SbN₃ - the first Sb-based nitride and a photoactive semiconductor. Surprisingly, Zn₂SbN₃ contains Sb in the highest (+5) oxidation state with unusual tetrahedral coordination. This new Zn₂SbN₃ material has a solar-matched 1.6-1.7 eV band gap and shows near-band-edge room-temperature photoluminescence, demonstrating its promise as an optoelectronic semiconductor. Finally, Zn₂SbN₃ can be synthesized at low temperature in a wide range of processing conditions, despite being metastable according to theoretical calculations. All these results, as well as the band position measurements, indicate that Zn₂SbN₃ is a promising emerging semiconductor for applications as an absorber in photovoltaic and photoelectrochemical solar cells.

Keywords:

Ternary nitrides, combinatorial sputtering, solar absorber, zinc antimony nitride

Introduction.

Wurtzite-based ternary nitrides have been widely studied in recent years as potential replacements for costly III-V materials for optoelectronic applications. Members of the original family of II-IV-N₂ - such as ZnSnN₂, ZnGeN₂, and ZnSiN₂ - arose as structural analogs to III-V materials, where the group III element is replaced by a combination of elements from the adjacent groups.¹ Among these, ZnSnN₂ received substantial attention for its potential to overcome the miscibility gap present in traditional III-Vs that leads to the possibility of tuning the bandgap by controlling the disorder on the cation sublattice and the ratio between the two cations (Zn and Sn).^{2, 3} Control of the carrier concentration has been challenging, and only recently have photovoltaic (PV) devices based on this material been demonstrated.⁴ Recently, we showed that the family of wurtzite-derived materials - also known as tetrahedrally bonded nitrides - extends far beyond the II-IV-N₂ stoichiometry to include II₃-VI-N₄ and II₂-V-N₃ stoichiometries (with VI and V being transition metal or main group elements).^{5, 6}

Most of the cations in the periodic table have been reported to form nitrides in either monometallic or bimetallic compounds⁷⁻¹⁰. To date, an exception to this rule is represented by antimony (Sb). Among the binaries Sb-nitrides predicted, both SbN¹¹ and Sb₃N¹² were only realized in amorphous thin-film form.^{13, 14} Despite having a relatively high electronegativity (EN = 1.9), synthesis challenges arise because Sb tends to react quickly with any residual moisture or oxygen present in the growth environment to form amorphous oxynitrides. Regarding crystalline Sb-based ternary nitrides, the ICDD database reports only mixed-anion anti-perovskite antimonide-

nitrides, i.e., compounds having M-Sb-N stoichiometry (M being a metal, Sb being in the -3 oxidation state). Examples of these compounds include Mn_3SbN ^{15, 16} or those formed with alkaline-earth metals such as AE_3SbN ,¹⁶⁻¹⁸ where AE is Mg, Ca, Sr, or Ba. Theoretical predictions also exist for $\text{BSb}_{1-x}\text{N}_x$ alloys,¹⁹ where the identical electronegativity of B and Sb would likely lead to strongly covalent semiconductors. As a result, to date, there is no experimental evidence of crystalline nitrides where Sb functions as a cation (positive oxidation state). In this paper, we present the synthesis and characterization of the functional properties of Zn_2SbN_3 , the first ternary antimony nitride.

Results and Discussion.

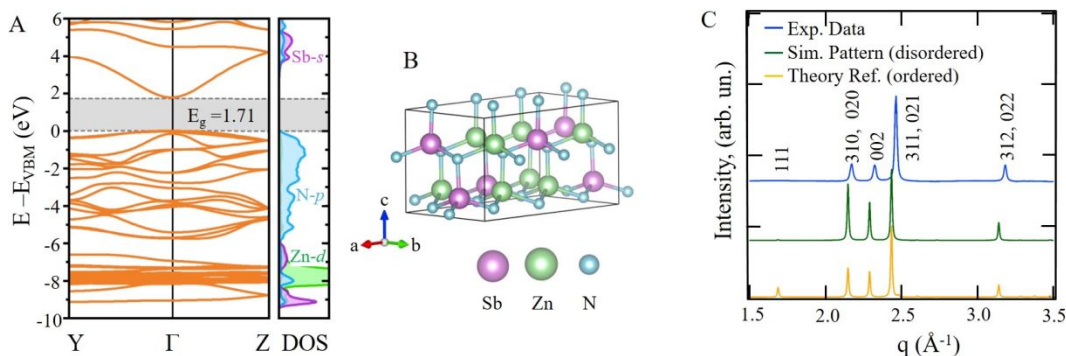


Figure 1. A) Band-structure calculations of the Zn_2SbN_3 phase and B) its crystal structure; C) Experimental X-Ray Diffraction pattern for a composition of $f_{\text{Zn}} = 0.68$ compared to the theoretical reference.

High-throughput calculations have identified Zn_2SbN_3 as a possible interesting chemical semiconductor.⁶ The Zn_2SbN_3 phase is metastable and requires a minimum $\Delta\mu_{\text{N}} \geq +0.5$ eV above the nitrogen gas chemical potential, which has previously been

shown to be within range of non-equilibrium growth methods, such as reactive magnetron sputtering (Fig. SI1). The calculated band structure for the wurtzite-derived orthorhombic ground-state structure (SG 36, Figure 1B) is shown in Figure 1A, and it reveals compelling properties for optoelectronic applications.

The fundamental bandgap is 1.71 eV and is direct at the Γ point. The electron effective mass is anisotropic and very low in both directions: 0.15 m_e and 0.19 m_e parallel and perpendicular, respectively, to the wurtzite-derived equivalent c -axis. These low values are a consequence of the concave shape of the conduction band minimum, which results in highly dispersed bands. The density-of-states hole effective mass is 2.4 m_e , which is very close to the value calculated for GaN.²⁰

We performed synthetic exploration of this chemical system using combinatorial sputtering from Zn and Sb targets on Eagle XG glass. Details of the growth conditions are reported in SI2. In line with the theoretical stability phase diagram (Figure SI1), the wurtzite-derived crystal structure shows stability over a wide composition region from $f_{Zn} \sim 0.8$ to ~ 0.5 , with f_{Zn} being the Zn cation fraction $Zn/(Zn+Sb)$. Films crystallize in the wurtzite-derived structure even when no heat is intentionally supplied during the growth and up to 300°C (Figure SI2). To ensure purity of the phase, we performed synchrotron-based X-Ray Diffraction (XRD) on selected spots of the combinatorial libraries. An example is given in Figure 1C for a stoichiometry of $f_{Zn} = 0.68$ as determined by X-Ray Fluorescence (XRF). All peaks present in the XRD pattern can be indexed to those of Zn_2SbN_3 in the wurtzite-derived structure. The XRD pattern simulated for the orthorhombic ground state of Zn_2SnN_3 (“theory ref.” in Figure 1C) shows additional peaks - most notably, the (111) reflection that has zero intensity in

ideal wurtzite- that originate from ordering in the cation sublattice. The absence of these features in the experimental diffraction indicates that these films are cation disordered (disorder-simulated pattern in Figure 1C), although a high degree of short-range order is nevertheless possible.²¹ The diffraction peaks are sharp and intense, indicating large diffraction domains. A small shift to larger q , corresponding to smaller unit cell, is observed, possibly caused by strain build into the film during deposition, or variation in stoichiometry for example due oxygen impurities.

XRF is not suitable for measuring light elements such as N, so the full stoichiometry was determined by Rutherford Back Scattering (RBS) for several points across the deposited sample library (Table SI1). For a composition of $f_{Zn} = 0.65$ as determined by XRF, the complete composition (determined by RBS) is $Zn_{1.7}SbN_3$. Oxygen contamination was present in these films in a low concentration (8.5% on the anion site) as shown in Table SI1. Thus, compositional and structural characterization confirmed the existence of the theoretically predicted Zn_2SbN_3 phase in the wurtzite-derived structure.

It is interesting to note that based on formal electron counting,²² Sb is in its highest oxidation state, +5, and it is tetrahedrally coordinated. Fourfold coordination is rather uncommon for Sb (+5), which is most often encountered in octahedral coordination; this is in contrast to Sb (+3), for which tetrahedral coordination is very common.^{23, 24}

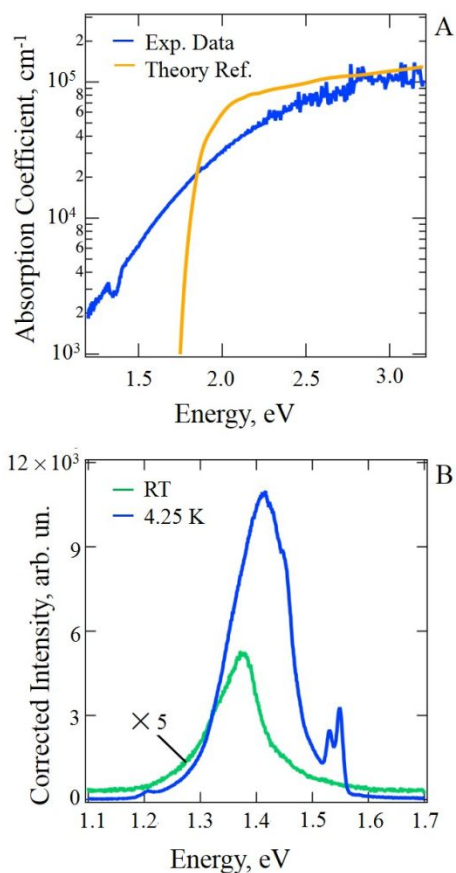


Figure 2. A) Comparison between the theoretically calculated and experimentally measured absorption coefficient for a Zn_2SbN_3 film. B) Photoluminescence (PL) measurements done on a stoichiometric film at low and room temperature (RT), respectively. The RT PL spectrum was magnified by a factor of 5 to compare it with the spectrum acquired at low temperature.

X-ray Photoelectron Spectroscopy (XPS) was performed on a film grown at room temperature to assess its chemical state at the surface (Figure SI3). To this end, a small portion of the sample, having composition $f_{\text{Zn}} = 0.65 \pm 0.02$, was cut out from the combinatorial library and loaded into the XPS instrument. The Zn 2p_{3/2} and Sb 3d_{5/2}

core levels are positioned at 1021.6 eV and 530.5 eV, respectively. These binding energies are comparable to those observed for the same core levels in other Zn-Sb compounds where Sb is present in the +5 oxidation state.²⁵⁻²⁷ Additional bulk-sensitive measurements would be required to confirm these results obtained using a surface-sensitive technique.

Optical properties were characterized by UV-Visible spectroscopy (UV-Vis) and photoluminescence (PL) measurements. The experimental absorption coefficient determined by UV-Vis is reported in Figure 2A as well as the value predicted theoretically according to Density Functional Theory (DFT) calculations. The experimental and theoretical data agree in terms of the overall intensity of the absorption coefficient. GW-corrected DFT calculations predict the fundamental bandgap to be 1.71 eV with a very steep absorption onset, which compares to a more gradual onset around 1.4–1.5 eV from experimentally measured UV-Vis spectroscopy (Figure 2A and Figure SI4). This discrepancy could originate from cation disorder and off-stoichiometry, which could cause Urbach-like tail states.²¹

PL emission was observed in these films at both low temperature (LT) and room temperature (RT). Figure 2B shows PL emission recorded at 4.25 K and RT using an excitation wavelength of 632.8 nm at 10-mW power for a small portion of the library grown at 300°C and having a composition $f_{\text{Zn}} = 0.68$. The LT measurements show a sharp peak at higher energy (1.55 eV) and a much broader peak at lower energy (1.4 eV). These PL features are similar to those observed in ZnSnN₂, where a more detailed analysis has shown that the broad feature is likely defect-related and the sharp feature is excitonic emission close to the fundamental bandgap.³ Therefore, we tentatively

assign the higher-energy feature to bound-exciton emission, which would place the bandgap at about 1.55 eV - noting that this bandgap may deviate slightly from ideal Zn_2SbN_3 due to disorder and O incorporation.

It is quite remarkable to observe this sharp near-gap excitonic PL despite the tail present in the absorption data. To confirm the attribution of this PL activity to the Zn_2SbN_3 phase, we performed Transmission Electron Microscopy (TEM) analysis and Energy-Dispersive X-ray spectroscopy mapping (EDX) (Figure SI5). Both confirm that the material is polycrystalline, with no presence of secondary phases, and elements are homogeneously distributed across the probed area. This demonstrates that Zn_2SbN_3 is a photoactive material.

Resistance vs temperature measurements were performed on several samples, with an example reported in Figure SI6. The temperature-activated resistivity confirms that Zn_2SbN_3 has semiconducting behavior. Hall measurements were performed on a small portion of a library grown at 300°C and having $f_{\text{Zn}} = 0.64$ at RT. A Hall voltage of -2.9 cm^3C^{-1} was measured, indicating that the material is an n-type semiconductor. The mobility of the sample was measured to be $0.1 \text{ cm}^2\text{V}^{-1}\text{s}^{-1}$ with a carrier concentration of $2 \times 10^{18} \text{ cm}^{-3}$, a value already suitable for optoelectronic applications. Based on theoretical studies carried out on similar wurtzite compounds such as ZnSnN_2 and ZnGeN_2 , oxygen incorporation could be a possible source of n-type carriers, when present in dilute concentrations^{28, 29}. Additional theoretical studies to understand the defect chemistry of Zn_2SbN_3 would be required to conclusively determine the nature of the intrinsic defects and assess their role in the observed n-type conductivity.

Scattering at defect centers and at grain boundaries can explain the observed low electron mobility in Zn_2SbN_3 thin films reported here, despite the very low theoretical effective mass predicted for this material. Density of defects that are present in thin films sputtered on glass can be reduced by improving the crystal quality of the material, leading to a large improvement in the mobility. Recently this has been demonstrated for Mg-based nitrides such as MgZrN_2 , for which mobility was improved by more than an order of magnitude using the templating effect of epitaxial substrates^{30, 31}. Similar epitaxial methods or alternative growth techniques can be envisioned to reduce the defect density and improve the electron mobility in Zn_2SbN_3 .

Optical and electrical properties of Zn_2SbN_3 were characterized as a function of composition within the crystalline range ($65 \leq f_{\text{Zn}} \leq 80$). Electrical properties vary substantially over this compositional range, with the material becoming completely insulating toward the two extremes of Zn-rich or Sb-rich values (Figure SI7). Contrary to many other wurtzite-derived nitrides, the optical absorption onset remains almost constant in the compositional range tested. This means that additional tuning of the carrier concentration might be possible by controlling the cation ratio.

To fully assess the potential of Zn_2SbN_3 as photoactive material, we performed XPS and ultraviolet photoelectron spectroscopy (UPS). A sample library was grown without intentional substrate heating at 20 mTorr and small piece of it, having composition $f_{\text{Zn}} = 0.65 \pm 0.02$, was cut out and loaded into the XPS system (Figure 3). This composition was chosen to correspond to the highest conductivity to facilitate the measurements. Air-free transfer was not possible for this sample, thus the quantities reported below are valid for air-exposed films. The position of the valence band maximum (VBM) is

1.3±0.05 eV below the Fermi level. This indicates a moderately n-type material, in good agreement with the electrical measurements. UPS measurements were performed to determine the material work function and thus its ionization potential, which were found to be 4.2 eV and 5.5 eV, respectively (Figure 3). The electron affinity (EA) is then determined by summing the bandgap value. Depending on whether we use the experimental bandgap determined by PL (1.55 eV) or the theoretical value (1.71 eV), the EA is found to be 3.95 eV or 3.79 eV, respectively.

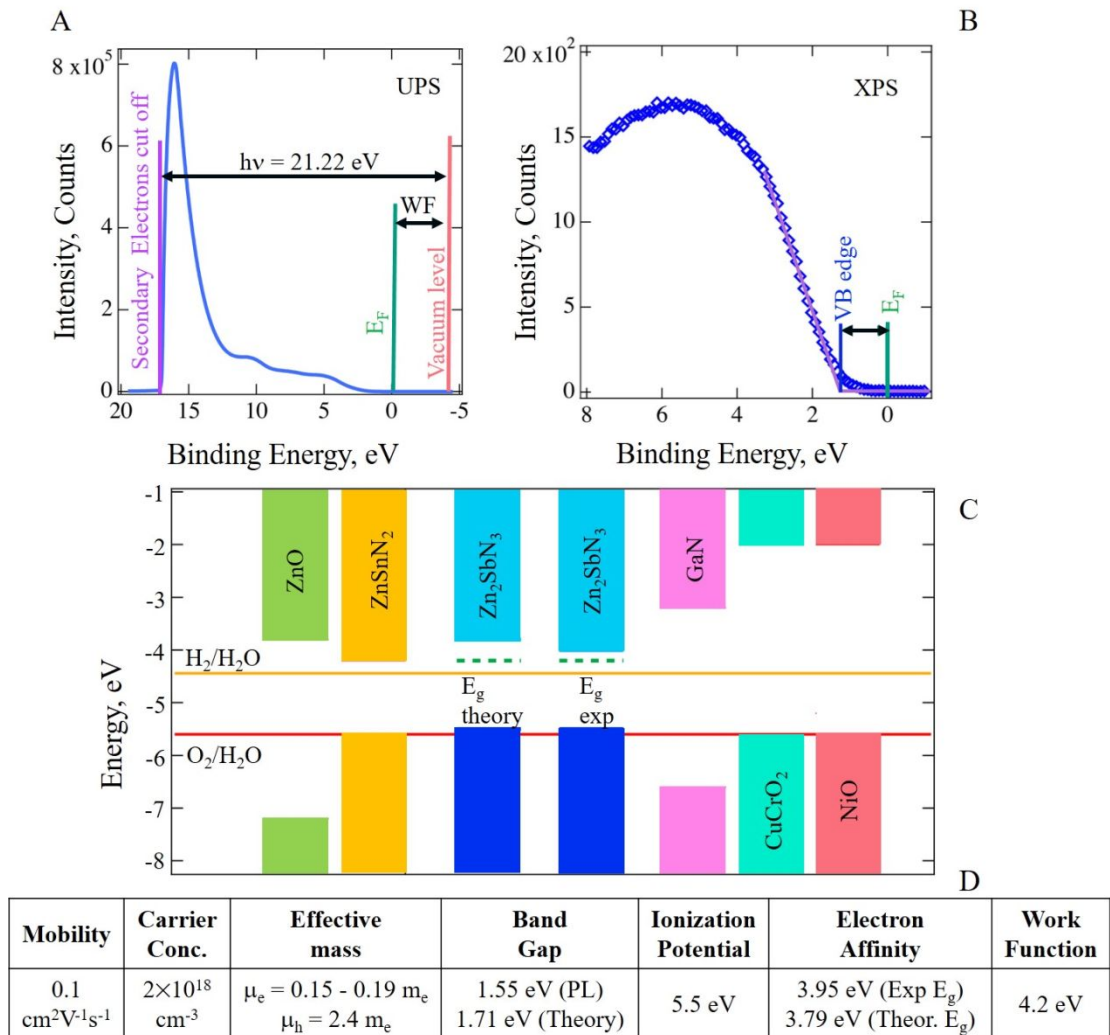


Figure 3. A) Work function (WF) determined by UPS measurements on a sample grown at RT and having composition $f_{Zn} = 0.65 \pm 0.02$; B) VBM measured by XPS. C) Vacuum-level alignment for the Zn_2SbN_3 sample measured in this work. Comparison to other materials have been taken from Ref. ³²; D) Summary table of the optoelectronic properties of Zn_2SbN_3 .

The low effective masses, moderate n-type conductivity, and observed RT photoluminescence (Figure 3D) make this material compelling for further exploration as a solar absorber. In particular, the 1.71-eV bandgap predicted by theory is ideal for a two-junction solar cell using a silicon bottom cell. With respect to other wurtzite-derived nitrides such as $ZnSnN_2$ that have been studied as PV absorbers, Zn_2SbN_3 has the advantage of having carrier concentration already suitable for implementing it in PV devices in its as-deposited form, without needing post-annealing treatments to reduce the native carrier concentrations.³³⁻³⁵ Suitable junction partners would include traditional p-type transparent conducting oxides, such as $CuCrO_2$ or NiO , whereas GaN appears to be unsuitable because of the expected large valence-band offset. The position of the Zn_2SbN_3 VBM is relatively high, and the low native carrier concentration might make this material more prone to p-type doping using extrinsic impurities than similar nitrides such as $ZnSnN_2$.³⁶ Furthermore, based on the position of the conduction band minimum with respect to the H_2/H_2O level, this material is worth further investigation for Hydrogen Evolution Reactions (HERs) in water splitting. The suitability of nitrides for water-splitting applications has often been questioned because of nitrides' thermodynamic instability under the corrosive

conditions used for HER. However, it was recently demonstrated that surface engineering and controlling the termination of carefully grown nanowires can allow GaN to perform in photoelectrochemical devices for hundreds of hours, despite its well-known thermodynamic instability in the acidic environment used.^{37, 38} Regarding the Oxygen Evolution Reactions (OERs), the VBM is only 0.1 eV higher than the O₂/H₂O potentials. In principle, this material could also be investigated for O₂/H₂O; however, its suitability as an OER largely depends on whether there is downward band-bending of the valence band upon exposure of the materials to the pH = 0 solution, which is a phenomenon often observed.³⁷

Conclusions.

In conclusion, we grew and characterized Zn₂SbN₃, the first-ever-reported Sb-based nitride semiconductor and a new metastable ternary nitride. This material presents highly interesting properties such as the high +5 oxidation state of Sb, coupled with an unusual tetrahedral coordination environment. From an application standpoint, this semiconductor presents compelling functionalities: a direct theoretical bandgap of 1.71 eV (experimental 1.55 eV), carrier concentrations in the range suitable for device applications, and room-temperature photoluminescence. All these properties make Zn₂SbN₃ worth further investigation as a PV absorber and for HERs in water splitting.

Author contributions

E.A. and A. Z. conceived the idea, supervised experiments, and drafted the manuscript.

E. A. prepared and characterized samples; J. D. P. carried out the RBS measurements; S. L., W.S., A.H. and G.C. performed the theoretical studies, A. M. carried out TEM measurements; B.-R.C., M.F.T and L.T.S performed the XRD synchrotron experiments, P. D. and A.C.T. performed and analyzed the PL measurements, J.L.P. performed the UV-Vis measurements under the supervision of E.A. and A.Z.; W.T. oversaw the overall EFRC project, E.A. and G. T. performed the XPS experiments. All co-author reviewed the manuscript.

Conflicts of interest

The authors declare no conflict of interests.

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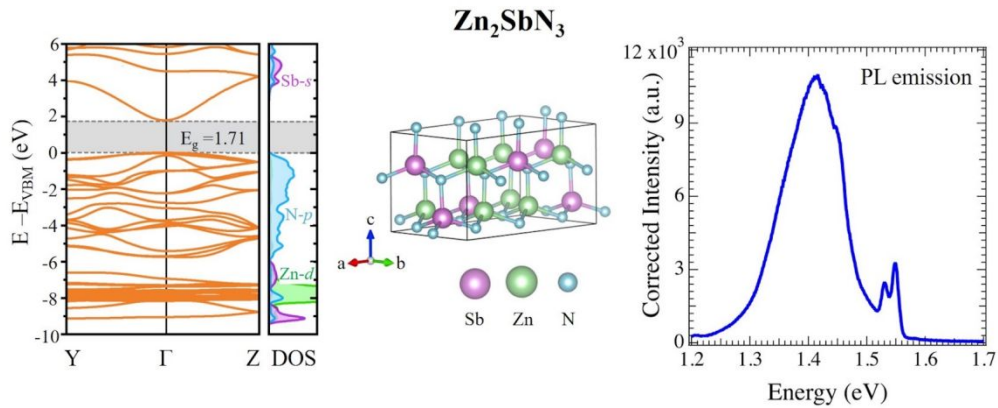
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Zn₂SbN₃ is the first Sb-based crystalline nitride and a photoactive semiconductor